


<b>Search Notes</b>  	<b>Application/Control No.</b>  10824439	<b>Applicant(s)/Patent Under Reexamination</b>  SAWANO, TETSUYA
	<b>Examiner</b>  Herrera, Diego	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
455	456.3	4/2/2007	dh
above	updated search	9/13/2007	dh
above	updated search	3/20/2008	dh
above	updated search	11/20/2008	dh

SEARCH NOTES		
Search Notes	Date	Examiner
test search east, combiantion with class search, and spoke to lewis west for class search	4/2/2007	dh
above search updated	9/13/2007	dh
above search updated, plus search introduced, and talked to lester kincaid, phuoc doan, and charles schedrick	11/18/2008	dh

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/DIEGO HERRERA/ Examiner.Art Unit 2617	
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